Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/540,278	MATHIEU ET AL.	
Examiner	Art Unit	
Tho G. Phan	2821	

	SEAR	CHED	
Class	Subclass	Date	Examiner
343	700ms,867 ,895	6/6/2007	TP
430	311,315	6/6/2007	TP
235	492	6/6/2007	TP
340	572.5	6/6/2007	TP

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH (INCLUDING SEAR		')
	DATE	EXMR
search history attached	6/6/2007	ТР